



Product Change Notification / GBNG-09ECUY508

Date:

18-Oct-2022

Product Category:

Crypto Authentication

PCN Type:

Manufacturing Change

Notification Subject:

CCB 5249 Final Notice: Qualification of MTAI as an additional assembly site for selected ATECC108A, ATECC508A, ATSHA204A, ATECC608A, ATECC608B and ECC608-TFLXWPC device families available in 8L SOIC (3.90mm) package using QMI519 die attach material.

Affected CPNs:

[GBNG-09ECUY508_Affected_CPN_10182022.pdf](#)

[GBNG-09ECUY508_Affected_CPN_10182022.csv](#)

Notification Text:

PCN Status:Final Notification

PCN Type:Manufacturing Change

Microchip Parts Affected:Please open one of the files found in the Affected CPNs section.

Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

Description of Change:Qualification of MTAI as an additional assembly site for selected ATECC108A, ATECC508A, ATSHA204A, ATECC608A, ATECC608B and ECC608-TFLXWPC device families available in 8L SOIC (3.90mm) package using QMI519 die attach material.

Pre and Post Change Summary:

	Pre Change	Post Change
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Implementation Date																				
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Method to Identify Change:Traceability Code

Qualification Report:Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:September 13, 2022: Issued initial notification.
October 18, 2022: Issued final notification. Attached the Qualification Report. Revised the Impact to datasheet from Yes to None. Revised the ASSH plant name from ASE Advanced Semiconductor (Shanghai) Co., Ltd. to ATX Semiconductor (Shanghai)Co., Ltd. Provided estimated first ship date to be on October 31, 2022.

The change described in this PCN does not alter Microchip’s current regulatory compliance regarding the material content of the applicable products.

Attachments:

- [PCN_GBNG-09ECUY508 Qual Report.pdf](#)
- [PCN_GBNG-09ECUY508_Pre and Post Change_Summary.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

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GBNG-09ECUY508 - CCB 5249 Final Notice: Qualification of MTAI as an additional assembly site for selected ATECC108A, ATECC508A , ATSHA204A , ATECC608A

ATECC608B and ECC608-TFLXWPC device families available in 8L SOIC (3.90mm) package using QMI519 die attach material.

Affected Catalog Part Numbers(CPN)

ATSHA204A-SSHMD-B
ATSHA204A-SSHDA-B
ATSHA204A-SSH1S-B
ATSHA204A-SSHDA-T
ATSHA204A-SSHCZ-T
ATSHA204A-TCSMS
ATECC608B-SSHMD-B
ATECC608A-TNGACTS-B
ATECC608B-TNGACTS-B
ATECC608B-SSHCZ-B
ATECC608B-SSHDA-B
ATECC608A-TNGLORAS-B
ATECC608A-SSHMD-B
ATECC608B-TNGLORAS-B
ATECC608B-TNGTLSS-B
ATECC608B-TFLXTLSS-PROTO
ATECC608A-TNGTLSS-B
ATECC608A-TFLXTLSS-PROTO
ATECC108A-SSHDA-B
ATECC108A-SSHCZ-B
ATECC508A-SSHDA-B
ATECC508A-SSHCZ-B
ATECC508A-SSHHL-B
ATECC508A-SSHRA-B
ATECC508A-SSHMT-B
ATECC608A-SSHDA-B
ATECC608A-SSHCZ-B
ATECC608A-SSHHL-B
ATECC508A-SSH1P-T
ECC608-TFLXWPCS-PROTO
ATECC608B-SSVDA-B
ATECC608B-SSVHL-T
ATECC608B-SSVDA-T
ATECC608B-SSHHL-T
ATECC108A-SSHDA-T
ATECC108A-SSHCZ-T
ATECC508A-SSHDA-T
ATECC508A-SSHCZ-T
ATECC508A-SSHHL-T
ATECC508A-SSHRA-T
ATECC508A-SSHMT-T
ATECC508A-SSHZC-T
ATECC508A-SSHZJ-T
ATECC508A-SSHAW-T
ATECC508A-SSHWA-T
ATECC508A-SSHC9-T
ATECC608A-SSHDA-T
ATECC608A-SSHCZ-T
ATECC608A-SSHHL-T
ATECC608A-SSH4P-T
ATECC608A-TNGACTS-C
ATECC608B-TNGACTS-C
ATECC608A-TNGLORAS-C
ATECC608B-TNGLORAS-C
ATECC608B-TNGTLSS-C
ATECC608A-TNGTLSS-C

ECC608-TFLXWPCS
ATECC608A-TNGACTS-G
ATECC608B-TNGACTS-G
ATECC608A-TNGLORAS-G
ATECC608B-TNGLORAS-G
ATECC608B-TNGTLSS-G
ATECC608A-TNGTLSS-G
ATECC508A-SSH1F-T
ATECC508A-SSH1M-T
ATECC608A-SSH4N-T
ATECC508A-SSHC6-T
ATECC508A-SSH1L-T
ATECC608A-SSH2P-T
ATECC608A-SSH3M-T
ATECC608B-SSH3S-T
ATECC608B-SSHA5-T
ATECC608B-SSHA6-T
ATECC608B-SSHCZ-T
ATECC608B-SSHDA-T
ATECC608A-SSHGA-T
ATECC608B-SSHKA-T
ATECC608A-SSHXA-T
ATECC608B-TCSMS
ATECC608B-TFLXTLSS
ATECC608A-TCSMS
ATECC608A-TFLXTLSS



QUALIFICATION REPORT SUMMARY
RELIABILITY LABORATORY

PCN#: GBNG-09ECUY508

Date
October 12, 2022

Qualification of MTAI as an additional assembly site for selected ATECC108A, ATECC508A, ATSHA204A, ATECC608A, ATECC608B and ECC608-TFLXWPC device families available in 8L SOIC (3.90mm) package using QMI519 die attach material.



MICROCHIP
PACKAGE QUALIFICATION REPORT

Purpose	Qualification of MTAI as an additional assembly site for selected ATECC108A, ATECC508A, ATSHA204A, ATECC608A, ATECC608B and ECC608-TFLXWPC device families available in 8L SOIC (3.90mm) package using QMI519 die attach material.
QUAL ID	R2200905 Rev B
MPC CODE	58962TC2XTXA
Part No.	ATECC608A-SSHXA-T
Bonding No.	BD-000861 Rev. 02
CCB No.	5249
<u>Package</u>	
Type	8L SOIC
Package size	150 mils
<u>Lead Frame</u>	
Paddle size	90x90 mils
Material	CDA194
Surface	Bare Cu
Process	Stamped
Lead Lock	No
Part Number	10100812
Treatment	BOT
<u>Material</u>	
Epoxy	QMI519
Wire	CuPdAu
Mold Compound	G600V
Plating	
Composition	Matte Sn



MICROCHIP PACKAGE QUALIFICATION REPORT

Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
MTAI231902058.000	U8CD923045545.120	2232Q2Y
MTAI231902378.000	U8CD923045545.120	2232R44
MTAI232000036.000	U8CD923045545.120	2233RD1

Result



Pass



Fail



8L SOIC (150 mils) assembled by MTAI pass reliability test per QCI-39000.
This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C
reflow temperature per IPC/JEDEC J-STD-020E standard.

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
Precondition Prior Perform Reliability Tests (At MSL Level 1)	Electrical Test: +25°C, 85°C and 100°C System: NEXTEST_PT	JESD22- A113	693(0)	693		Good Devices
	Bake 150°C, 24 hrs.	JIP/		693		
	System: CHINEE	IPC/JEDEC		693		
	85°C/85%RH Moisture Soak 168 hrs.	J-STD- 020E		693		
	System: TABAI ESPEC Model PR- 3SPH			693		
3x Convection-Reflow 265°C max						
System: Vitronics Soltec MR1243						
	Electrical Test: +25°C, 85°C and 100°C System: NEXTEST_PT			0/693	Pass	

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks			
Temp Cycle	Stress Condition: -65°C to +150°C, 500 Cycles System: TABAI ESPEC TSA-70H Electrical Test: +85°C and 100°C System: NEXTEST_PT	JESD22A104	231(0)	231	Pass	Parts had been pre-conditioned at 260°C 77 units / lot			
	Stress Condition: -65°C to +150°C, 1000 Cycles System: TABAI ESPEC TSA-70H Electrical Test: +85°C and 100°C System: NEXTEST_PT			0/231			231		
	Bond Strength: Wire Pull (> 2.50 grams) Bond Shear (>15.00 grams)			0/231			231(0)	Pass	77 units / lot
				0/15			15 (0)	Pass	
UNBIASED-HAST	Stress Condition: +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22A118	231(0)	231	Pass	Parts had been pre-conditioned at 260°C 77 units / lot			
	Electrical Test: +25°C System: NEXTEST_PT			0/231					
HAST	Stress Condition: +130°C/85%RH, 96 hrs. Bias Volt: 5.5 Volts System: HAST 6000X	JESD22A110	231(0)	231	Pass	Parts had been pre-conditioned at 260°C 77 units / lot			
	Electrical Test: +25°C, 85°C and 100°C System: NEXTEST_PT			0/231					
	Stress Condition: +130°C/85%RH, 192 hrs. Bias Volt: 5.5 Volts System: HAST 6000X			231					
	Electrical Test: +25°C, 85°C and 100°C System: NEXTEST_PT			0/231			231(0)	Pass	77 units / lot

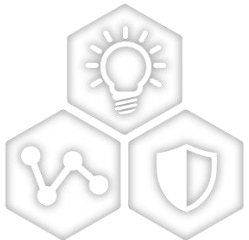
PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
High Temperature Storage Life	Stress Condition: Bake 175°C, 504 hrs System: SHEL LAB Electrical Test: +25°C, 85°C and 100°C System: NEXTEST_PT	JESD22-A103	45(0)	45 0/45	Pass	45 units
Solderability Temp 215°C	Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63, Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22 22 0/22	Pass	
Solderability Temp 245°C	Steam Aging: Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22 22 0/22	Pass	
Physical Dimensions	Physical Dimension, 10 units / 1 lot	JESD22-B100/B108	30(0) Units	0/30	Pass	
Bond Strength Data Assembly	Wire Pull (>3.00 grams)	Mil. Std. 883-2011	30 (0)	0/30	Pass	
	Bond Shear (>10.00 grams)	CDF-AEC-Q100-001	30 (0) bonds	0/30	Pass	

CCB 5249
Pre and Post Change Summary
PCN #: GBNG-09ECUY508



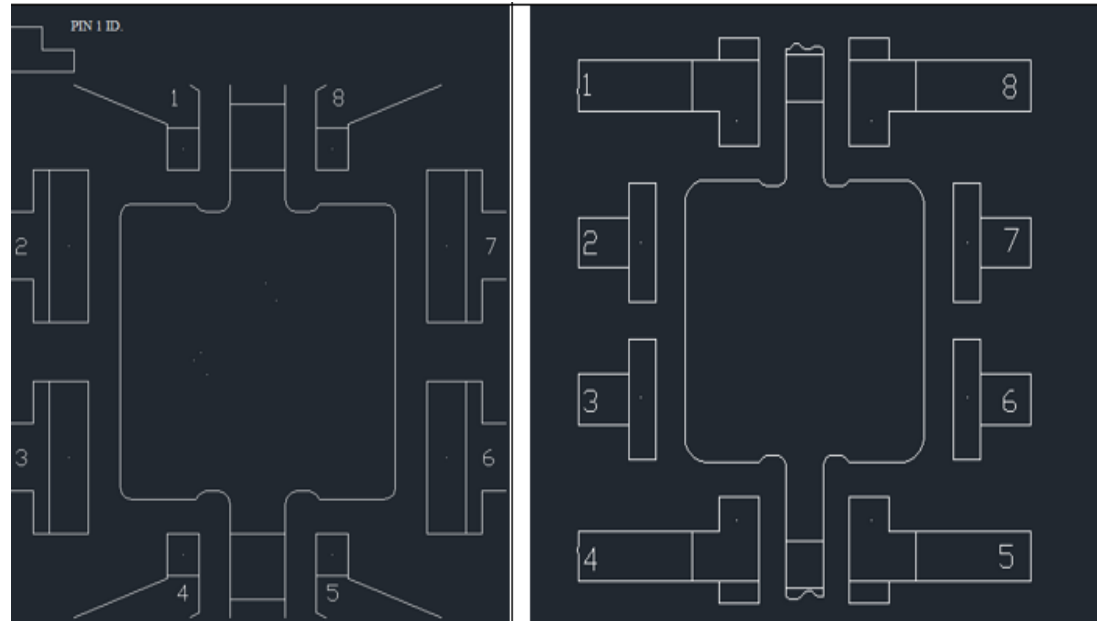
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SMART | CONNECTED | SECURE

LEAD FRAME COMPARISON

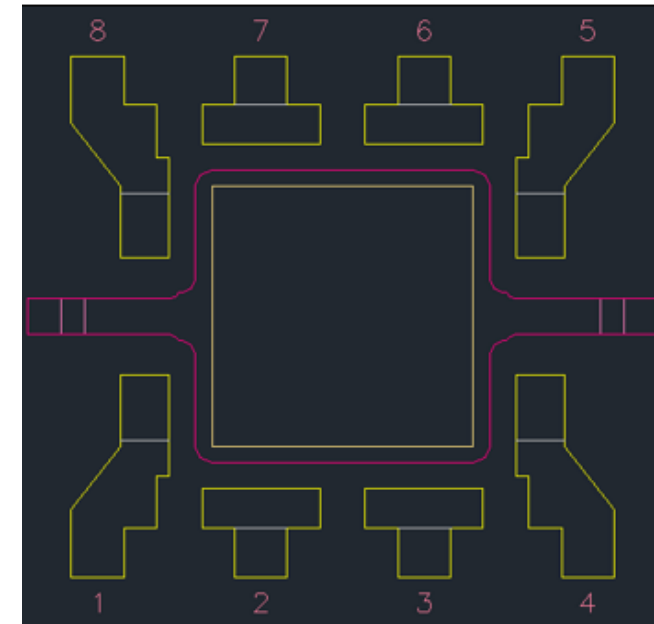
ASSH



Note: Not to scale

Lead frame DAP surface prep	PPF
Lead Plating	NiPdAu
Lead-Frame Paddle Size	70 x 70 / 90 x 90

MTAI



Note: Not to scale

Lead frame DAP surface prep	Bare Cu
Lead Plating	Matte tin
Lead-Frame Paddle Size	90 x 90